

SANYO	No.2973	2SA1699
		PNP Epitaxial Planar Silicon Transistor High-Voltage Driver Applications

Features

- High breakdown voltage
- Adoption of MBIT process
- Excellent h_{FE} linearity

Absolute Maximum Ratings at $T_a = 25^\circ\text{C}$

			unit
Collector to Base Voltage	V_{CBO}	-400	V
Collector to Emitter Voltage	V_{CEO}	-400	V
Emitter to Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-200	mA
Collector Current(Pulse)	I_{CP}	-400	mA
Collector Dissipation	P_C	600	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

Electrical Characteristics at $T_a = 25^\circ\text{C}$

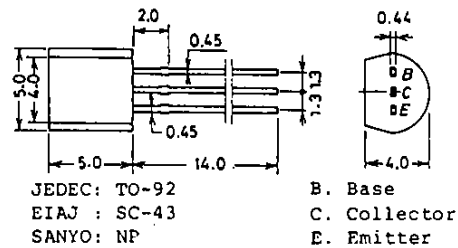
Collector Cutoff Current	I_{CBO}	$V_{CB} = -300\text{V}, I_E = 0$	min	typ	max unit
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -4\text{V}, I_C = 0$			-0.1 μA
DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -50\text{mA}$	60*		-0.1 μA
Gain-Bandwidth Product	f_T	$V_{CE} = -30\text{V}, I_C = -10\text{mA}$		70	200* MHz
C-E Saturation Voltage	$V_{CE(sat)}$	$I_C = -50\text{mA}, I_B = -5\text{mA}$			-0.8 V
B-E Saturation Voltage	$V_{BE(sat)}$	$I_C = -50\text{mA}, I_B = -5\text{mA}$			-1.0 V
C-B Breakdown Voltage	$V_{(BR)CBO}$	$I_C = -10\mu\text{A}, I_E = 0$	-400		V
C-E Breakdown Voltage	$V_{(BR)CEO}$	$I_C = -1\text{mA}, R_{BE} = \infty$	-400		V
E-B Breakdown Voltage	$V_{(BR)EBO}$	$I_E = -10\mu\text{A}, I_C = 0$	-5		V

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* : The 2SA1699 is classified by 50mA h_{FE} as follows :

60 D 120	100 E 200
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Package Dimensions 2003A
(unit: mm)



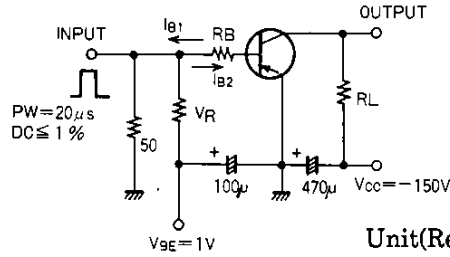
SANYO Electric Co., Ltd. Semiconductor Business Headquarters
TOKYO OFFICE Tokyo Bldg., 1-10, 1 Chome, Ueno, Taito-ku, TOKYO, 110 JAPAN

9149MO, TS No.2973-1/3

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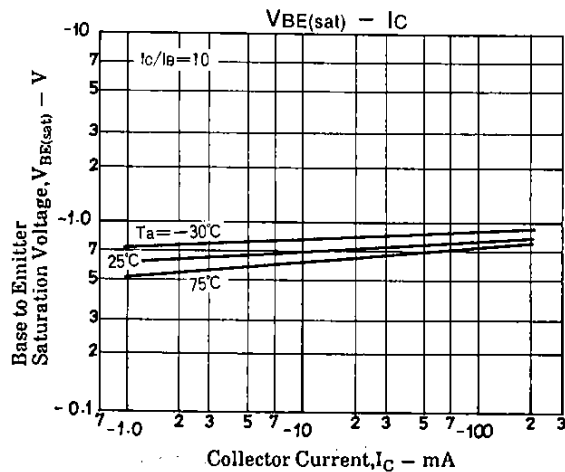
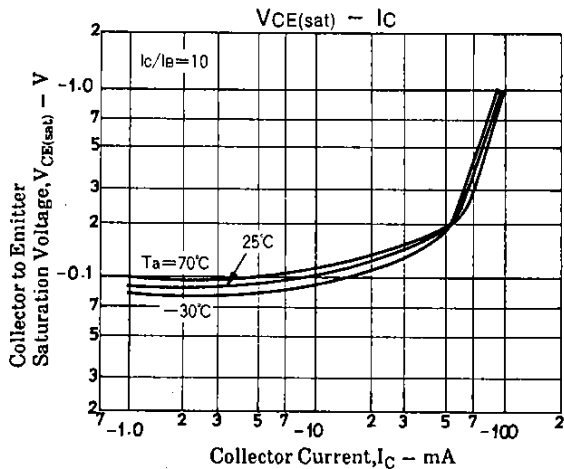
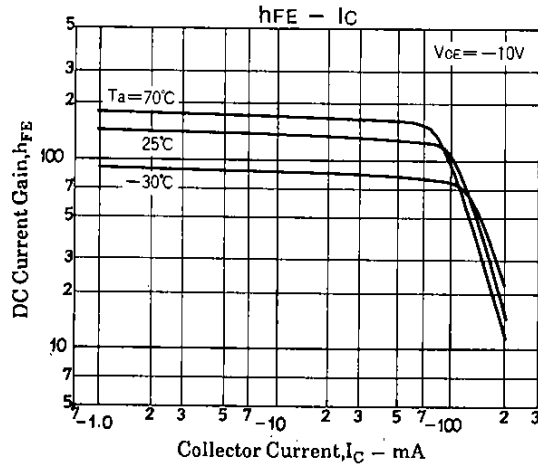
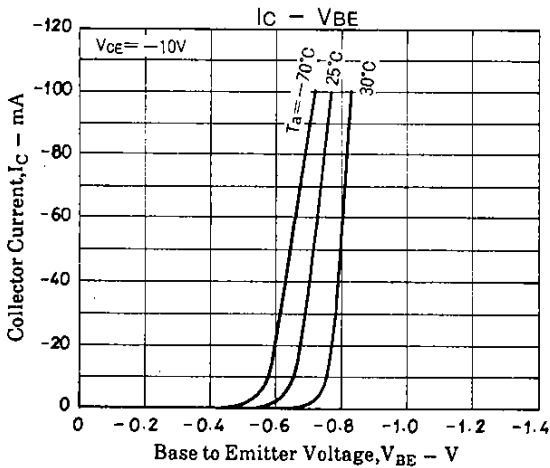
			min	typ	max	unit
Output Capacitance	C_{ob}	$V_{CB} = -30V, f = 1MHz$		5		pF
Reverse Transfer Capacitance	C_{re}	$V_{CB} = -30V, f = 1MHz$		4		pF
Turn-ON Time	t_{on}	See specified Test Circuit.		0.25		μs
Turn-OFF Time	t_{off}			5		μs

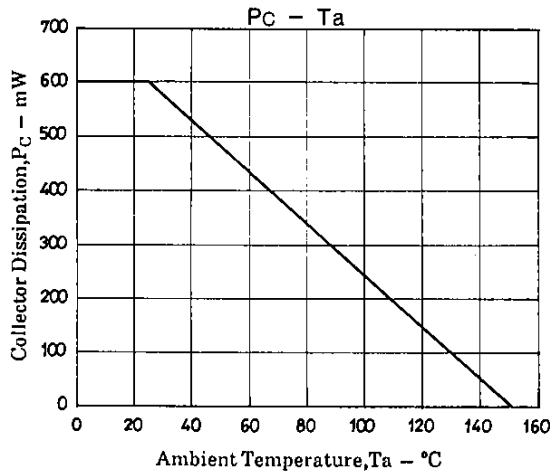
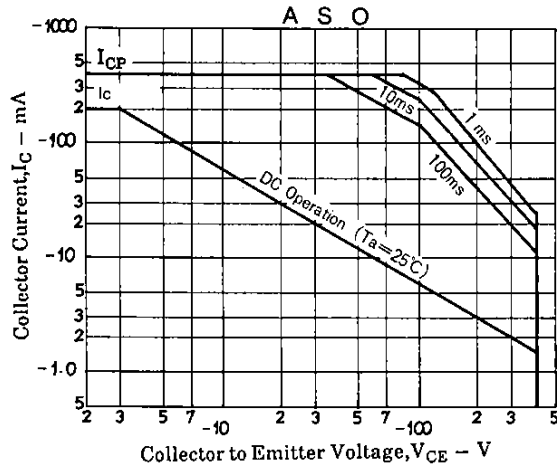
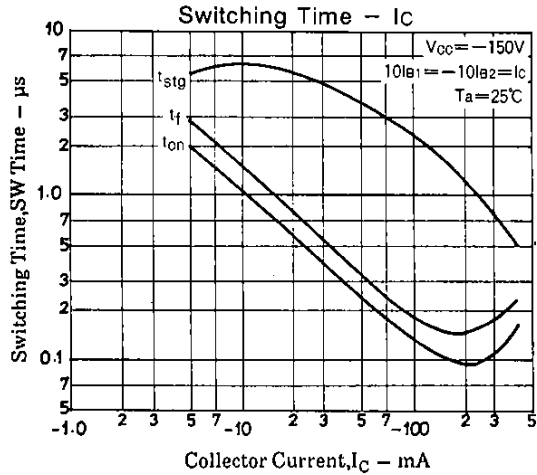
Switching Time Test Circuit



Unit(Resistance : Ω , Capacitance : F)

$-10I_{B1} = 10I_{B2} = I_C = -50mA$
 $R_L = 3k\Omega, R_B = 200\Omega$ at $I_C = -50mA$





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